

Notice of References Cited	Application/Control No. 10/602,020	Applicant(s)/Patent Under Reexamination REBLEWSKI ET AL.	
	Examiner Akash Saxena	Art Unit 2128	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0051866	12-2001	Ishii, Yasumasa	703/28
*	B	US-6,839,869	01-2005	Doi et al.	714/45
*	C	US-6,816,989	11-2004	Litt, Timothe	714/45
*	D	US-2005/0022067	01-2005	Baradie et al.	714/045
*	E	US-2002/0162055	10-2002	Kurooka et al.	714/45
*	F	US-5,276,854 A	01-1994	Court et al.	703/14
*	G	US-2001/0043122	11-2001	Swoboda, Gary L.	331/18
*	H	US-6,134,610	10-2000	Chung, Ji-Hwan	710/55
*	I	US-5,276,854	01-1994	Court et al.	703/14
*	J	US-5,680,583	10-1997	Kuijsten, Han	703/23
*	K	US-5,329,471	07-1994	Swoboda et al.	703/23
*	L	US-5,963,736	10-1999	Sarno et al.	703/27
*	M	US-5,884,066	03-1999	Kuijsten, Han	703/28

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Trace 32 ICE Emulator by www.Lauterbach.com (Webarchive date: http://web.archive.org/web/19980524175109/http://www.lauterbach.com/
	V	REAL-TIME DATA EXCHANGE; TI's debugger; Feb 1998; http://focus.ti.com/docs/apps/catalog/resources/appnoteabstract.jhtml?abstractName=spry012
	W	Code Composer Studio's Command Window; TI ; Nov 1999; http://focus.ti.com/docs/apps/catalog/resources/appnoteabstract.jhtml?abstractName=spra601
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/602,020	Applicant(s)/Patent Under Reexamination REBLEWSKI ET AL.	
	Examiner Akash Saxena	Art Unit 2128	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,392,420	02-1995	Balmer et al.	703/28
*	B	US-6,311,303	10-2001	Gates et al.	714/734
*	C	US-6,732,307	05-2004	Edwards, David Alan	714/724
*	D	US-5,796,939	08-1998	Berc et al.	714/47
*	E	US-4,554,661	11-1985	Bannister, Richard J.	714/45
*	F	US-5,379,416	01-1995	Takishima, Tohru	714/45
*	G	US-5,642,478	06-1997	Chen et al.	714/45
*	H	US-5,724,505	03-1998	Argade et al.	714/45
*	I	US-5,764,885	06-1998	Sites et al.	714/45
*	J	US-6,243,836	06-2001	Whalen, Shaun Patrick	714/45
*	K	US-6,367,036	04-2002	Hansen, Ole Brian	714/45
*	L	US-6,539,500	03-2003	Kahle et al.	714/45
*	M	US-6,918,065	07-2005	Edwards et al.	714/45

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/602,020	Applicant(s)/Patent Under Reexamination REBLEWSKI ET AL.	
	Examiner Akash Saxena	Art Unit 2128	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,266,789	07-2001	Bucher et al.	714/39
*	B	US-6,094,729	07-2000	Mann, Daniel P.	714/25
*	C	US-2003/0018929	01-2003	Bardsley et al.	714/39
*	D	US-2003/0046610	03-2003	Yamamoto et al.	714/34
*	E	US-6,055,492	04-2000	Alexander et al.	702/179
*	F	US-6,539,339	03-2003	Berry et al.	702/186
*	G	US-6,754,599	06-2004	Swoboda et al.	702/79
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.